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FSFA2100 — Fairchild Power Switch (FPS™) for Half-Bridge PWM Converters

Description

switching losses and noise.

system reliability.

The growing demand for higher power density and low

profile in power converter designs has forced designers

to increase switching frequencies. Operation at higher

frequencies considerably reduces the size of passive

components, such as transformers and filters. However,

switching losses have been an obstacle to highfrequency operation. To reduce switching losses and

allow high-frequency operation, Pulse Width Modulation

(PWM) with soft-switching techniques have been

developed. These techniques allow switching devices to

be softly commutated, which dramatically reduces the

FSFA2100 is an integrated PWM controller and

SuperFET™ specifically designed for Zero-Voltage-Switching (ZVS) half-bridge converters with minimal

external components. The internal controller includes an

oscillator, under-voltage-lockout, leading-edge blanking

(LEB), optimized high-side and low-side gate driver,

internal soft-start, temperature-compensated precise

current sources for loop compensation and self-

protection circuitry. Compared with discrete MOSFET and PWM controller solution, FSFA2100 can reduce total

cost; component count, size, and weight; while simultaneously increasing efficiency, productivity, and

Features

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- Optimized for Complementary Driven Half-Bridge Soft-Switching Converters
- Can be Applied to Various Topologies: Asymmetric PWM Half-Bridge Converters, Asymmetric PWM Flyback Converters, Asymmetric PWM Forward Converters, Active Clamp Flyback Converters
- High Efficiency through Zero-Voltage-Switching (ZVS)
- Internal SuperFET™s with Fast-Recovery Type Body Diode (t_{rr}=120 ns)
- Fixed Dead Time (200 ns) Optimized for MOSFETs
- Up to 300 kHz Operating Frequency
- Internal Soft-Start
- Pulse-by-Pulse Current Limit
- Burst-Mode Operation for Low Standby Power Consumption
- Protection Functions: Over-Voltage Protection (OVP), Over-Load Protection (OLP), Abnormal Over-Current Protection (AOCP), Internal Thermal Shutdown (TSD)

Applications

- PDP and LCD TVs
- Desktop PCs and Servers
- Adapters
- Telecom Power Supplies

Ordering Information

Part Number	Operating Junction Temperature	R _{ds(on_max)}	Maximum Output Power without Heatsink (V _{IN} =350~400 V) ^(1,2)	Maximum Output Power with Heatsink (V _{IN} =350~400 V) ^(1,2)	Package
FSFA2100	-40 to +130°C	0.38 Ω	200 W	450 W	9-SIP

Notes:

1. The junction temperature can limit the maximum output power.

2. Maximum practical continuous power in an open-frame design at 50°C ambient.

W For Fairchild's definition of "green" Eco Status, please visit: <u>http://www.fairchildsemi.com/company/green/rohs_green.html</u>.







Pin Definitions

Pin #	Name	Description			
1	V _{DL}	This is the drain of the high-side MOSFET, typically connected to the input DC link voltage.			
2	V_{FB}	is pin is connected to the inverting input of the PWM comparator internally and to the opto- upler externally. The duty cycle is determined by the voltage on this pin.			
3	R _T	This pin programs the switching frequency using a resistor.			
4	CS	nis pin senses the current flowing through the low-side MOSFET. Typically, negative oltage is applied on this pin.			
5	SG	his pin is the control ground.			
6	PG	is pin is the power ground. This pin is connected to the source of the low-side MOSFET.			
7	LV _{CC}	his pin is the supply voltage of the control IC.			
8	NC	No connection.			
9	HV _{CC}	This is the supply voltage of the high-side gate-drive circuit IC.			
10	V _{CTR}	This is the drain of the low-side MOSFET. Typically, a transformer is connected to this pin.			

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. $T_A=25^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Min.	Max.	Unit	
V _{DS}	Maximum Drain-to-Source Voltage (V _{DL} -	-V _{CTR} and V _{CTR-PG})	600		V
LV _{CC}	Low-Side Supply Voltage		-0.3	25.0	V
HV _{CC} to V _{CTR}	High-Side V _{CC} Pin to Low-Side Drain Vo	ltage	-0.3	25.0	V
HV _{cc}	High-Side Floating Supply Voltage		-0.3	625.0	V
V_{FB}	Feedback Pin Input Voltage		-0.3	LV _{CC}	V
V _{CS}	Current Sense (CS) Pin Input Voltage		-5.0	1.0	V
V_{RT}	R _T Pin Input Voltage		-0.3	5.0	V
dV _{CTR} /dt	Allowable Low-Side MOSFET Drain Vol	tage Slew Rate		50	V/ns
PD	Total Power Dissipation ⁽³⁾		12.0	W	
-	Maximum Junction Temperature ⁽⁴⁾		+150		
TJ	Recommended Operating Junction Tem	-40	+130	°C	
T _{STG}	Storage Temperature Range		-55	+150	°C
IOSFET Sec	ction				
V_{DGR}	Drain Gate Voltage (R_{GS} =1M Ω)		600		V
V _{GS}	Gate Source (GND) Voltage			±30	V
I _{DM}	Drain Current Pulsed			33	А
1	Continuous Drain Current	T _C =25°C	11		
Ι _D	Continuous Drain Current	T _C =100°C		7	A
Package Sec	tion		•		
Torque	Recommended Screw Torque		5	~7	kgf∙cm

Notes:

3. Per MOSFET when both MOSFETs are conducting.

4. The maximum value of the recommended operating junction temperature is limited by thermal shutdown.

Thermal Impedance

T_A=25°C unless otherwise specified.

Symbol	Parameter	Value	Unit
$\theta_{\rm JC}$	Junction-to-Case Center Thermal Impedance (Both MOSFETs Conducting)	10.44	°C/W
θ_{JA}	Junction-to-Ambient Thermal Impedance	80	°C/W

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
MOSFET Se	ection					
		I _D =200 μA, T _A =25°C	600			V
BV_{DSS}	Drain-to-Source Breakdown Voltage	I _D =200 μA, T _A =125°C		650		V
R _{DS(ON)}	On-State Resistance	V _{GS} =10 V, I _D =5.5 A		0.32	0.38	Ω
t _{rr}	Body Diode Reverse Recovery Time ⁽⁵⁾	V _{GS} =0 V, I _{Diode} =11.0 A, dI _{Diode} /dt=100 A/µs		120		ns
C _{ISS}	Input Capacitance ⁽⁵⁾	V _{DS} =25 V, V _{GS} =0 V,		1148		pF
C _{OSS}	Output Capacitance ⁽⁵⁾	f=1.0 MHz		671		pF
Supply Sect	tion				•	
I _{LK}	Offset Supply Leakage Current	HV _{CC} =V _{CTR} =600 V			50	μA
I_QHV_{CC}	Quiescent HV _{CC} Supply Current	(HV _{CC} UV+) - 0.1 V		50	120	μA
I _Q LV _{CC}	Quiescent LV _{CC} Supply Current	(LV _{CC} UV+) - 0.1 V		100	200	μA
1.1.87	Operating HV _{CC} Supply Current	f_{OSC} =100 KHz, V _{FB} > 3 V HV _{CC} =17 V		6	9	mA
I _o HV _{cc}	(RMS Value)	No switching, V_{FB} < 1V HV _{CC} =17 V		100	200	μA
I _o LV _{cc}	Operating LV _{CC} Supply Current	f_{OSC} =100 KHz, V _{FB} > 3 V		7	11	mA
10 - 1 00	(RMS Value)	No Switching, V _{FB} < 1 V		2	4	mA
UVLO Secti	on		1		T	
$LV_{CC}UV+$	LV_{CC} Supply Under-Voltage Positive Going Threshold (LV_{CC} Start)		13.0	14.5	16.0	V
LV _{CC} UV-	LV _{cc} Supply Under-Voltage Negative G	oing Threshold (LV _{CC} Stop)	10.2	11.3	12.4	V
LV _{CC} UVH	LV _{CC} Supply Under-Voltage Hysteresis			3.2		V
HV _{cc} UV+	HV _{CC} Supply Under-Voltage Positive Go	bing Threshold (HV _{CC} Start)	8.2	9.2	10.2	V
HV _{cc} UV-	HV _{cc} Supply Under-Voltage Negative G	oing Threshold (HV _{CC} Stop)	7.8	8.7	9.6	V
HV _{cc} UVH	HV_{CC} Supply Under-Voltage Hysteresis			0.5		V
Oscillator a	nd Feedback Section					
V _{RT}	V-I Converter Threshold Voltage		1.5	2.0	2.5	V
f _{osc}	Output Oscillation Frequency	R _T =27 KΩ	94	100	106	KHz
D_{MAX}	Maximum Duty Cycle	V _{FB} =4 V	45	50	55	%
D _{MIN}	Minimum Duty Cycle	V _{FB} =0 V			0	%
${\sf V}_{\sf FB}{}^{\sf MAX}$	Maximum Feedback Voltage for D_{MAX}	D _{MAX} ≥ 48%	2.7	3.0	3.3	V
I_{FB}	Feedback Source Current	V _{FB} =0 V	370	470	570	μA
V_{BH}	Burst Mode High-Threshold Voltage		1.34	1.50	1.66	V
V_{BL}	Burst Mode Low-Threshold Voltage		1.16	1.30	1.44	V
V_{BHY}	Burst Mode Hysteresis Voltage		0.1	0.2	0.3	V
t _{ss}	Internal Soft-Start Time	f _{osc} =100 kHz	10	15	20	ms

Continued on the following page...

Electrical Characteristics (Continued)

 $T_A {=} 25^\circ C$ and $LV_{CC} {=} 17$ V unless otherwise specified.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Protectio	n Section			•	•	
I _{OLP}	OLP Delay Current	V _{FB} =5 V	3.8	5.0	6.2	μA
V _{OLP}	OLP Protection Voltage	V _{FB} > 6 V	6.3	7.0	7.7	V
V _{OVP}	LV _{CC} Over-Voltage Protection	LV _{CC} > 21 V	21	23	25	V
VAOCP	AOCP Threshold Voltage	∆V/∆t=-1 V/µs	-1.0	-0.9	-0.8	V
t _{BAO}	AOCP Blanking Time ⁽⁵⁾	$V_{CS} < V_{AOCP};$ $\Delta V/\Delta t=-1 V/\mu s$		50		ns
t _{DA}	Delay Time (Low-Side) from V_{AOCP} to Switch Off ⁽⁵⁾	ΔV/∆t=-1 V/µs		250	400	ns
V_{LIM}	Pulse-by-Pulse Current Limit Threshold Voltage	ΔV/Δt=-0.1 V/μs	-0.64	-0.58	-0.52	V
t _{BL}	Pulse-by-Pulse Current Limit Blanking Time	$V_{CS} < V_{LIM};$ $\Delta V / \Delta t = -0.1 V / \mu s$		150		ns
t _{DL}	Delay Time (Low-Side) from V_{LIM} to Switch Off ⁽⁵⁾	ΔV/Δt=-0.1 V/μs		450		ns
T _{SD}	Thermal Shutdown Temperature ⁽⁵⁾		110	130	150	°C
I _{SU}	Protection Latch Sustain LV _{CC} Supply Current	LV _{CC} =7.5 V		100	150	μA
V _{PRSET}	Protection Latch Reset LV _{CC} Supply Voltage		5			V
Dead-Tim	ne Control Section					
D _T	Dead Time ⁽⁶⁾			200		ns

Notes:

5.

This parameter, although guaranteed, is not tested in production. These parameters, although guaranteed, are tested only in EDS (wafer test) process. 6.



Typical Performance Characteristics

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Functional Description

1. Internal Oscillator: FSFA2100 employs a currentcontrolled oscillator as shown in Figure 17. Internally, the voltage of the R_T pin is regulated at 2 V and the charging/discharging current for the oscillator capacitor C_T is determined by the current flowing out of the R_T pin (I_{CTC}). When the R_T pin is pulled down to the ground with a resistor R_{SET}, the switching frequency is fixed as:



Figure 17. Current Controlled Oscillator

2. PWM Control: Figure 18 shows the typical control circuit configuration. The opto-coupler transistor should be connected to the V_{FB} pin in parallel with the feedback capacitor to control the duty cycle.



Figure 18. PWM Control Configuration

Figure 19 shows the internal block diagram for PWM operation. Duty cycle is controlled by comparing the feedback voltage to the triangular signal with a range from 1 V to 3 V.



Figure 19. Internal PWM Block Diagram

3. Protection Circuits: The FSFA2100 has Overload Protection (OLP), Abnormal Over-Current Protection (AOCP), Over-Voltage Protection (OVP), and Thermal Shutdown (TSD) self-protective functions. The OLP and OVP are auto-restart mode protections, while the AOCP and TSD are latch-mode protections, as shown in Figure 20.

Auto-restart mode protection: Once the fault condition is detected, the switching is terminated and the MOSFETs remain off. When LV_{CC} falls down to LV_{CC} stop voltage of around 11V, the protection is reset. The FPS resumes normal operation when LV_{CC} reaches the start voltage of about 14 V.

Latch-mode protection: Once this protection is triggered, the switching is terminated and the MOSFETs remain off. The latch is reset only when LV_{CC} is discharged below 5 V.



Figure 20. Protection blocks

Low-side MOSFET current should be sensed for Pulseby-pulse current limit and AOCP. The FSFA2100 senses drain current as a negative voltage, as shown in Figure 21 and Figure 22. Half-wave sensing allows low-power dissipation in the sensing resistor, while full-wave sensing has less noise in the sensing signal.



Figure 21. Half-Wave Sensing



Figure 22. Full-Wave Sensing

3.1 Pulse-by-Pulse Current Limit: In normal operation, the duty cycle of the low-side MOSFET is determined by comparing the internal triangular signal with the feedback voltage. However, the low-side MOSFET is forced to turn off when the current sense pin voltage reaches -0.58 V. This operation limits the drain current below a predetermined level to avoid the destruction of the MOSFETs.

3.2 Abnormal Over-Current Protection (AOCP): If one of the secondary rectifier diodes is short-circuited, large current with extremely high di/dt can flow through the MOSFET before OCP or OLP is triggered. AOCP is triggered with a very short shutdown delay time when the sensed voltage drops below -0.9 V. This protection is latch mode and reset only when LV_{CC} is pulled below 5 V.

3.3 Overload Protection (OLP): Overload is defined as the load current exceeding its nominal level due to an unexpected abnormal event. In this situation, a protection circuit should trigger to protect the power supply. However, even when the power supply is in the normal condition, the OLP circuit can be triggered during the load transition. To avoid this undesired operation, the OLP circuit is designed to trigger only after a specified time to determine whether it is a transient situation or a

true overload situation. Because of the pulse-by-pulse current limit capability, the maximum peak current through the MOSFET is limited; and, therefore, the maximum input power is restricted with a given input voltage. If the output consumes more than this maximum power, the output voltage (Vo) decreases below the nominal voltage. This reduces the current through the opto-coupler diode, which also reduces the opto-coupler transistor current, increasing the feedback voltage (V_{EB}). If V_{FB} exceeds 3V, D1, which is illustrated in Figure 19, is blocked and the OLP current source starts to charge C_B slowly, as shown in Figure 23. In this condition, V_{FB} continues increasing until it reaches 7V, then the switching operation is terminated, as shown in Figure 23. The delay time for shutdown is the time required to charge C_B from 3V to 7V with 5µA, as given by:

FSFA2100

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Fairchild Power Switch (FPS[™]) for Half-Bridge PWM Converte

$$t_{delay} = \frac{(7V - 3V) \times C_B}{5\mu A}$$
(2)

A 30 ~ 50ms delay time is typical for most applications.



3.4 Over-Voltage Protection (OVP): When the LV_{CC} reaches 23V, OVP is triggered. This protection is enabled when using an auxiliary winding of the transformer to supply LV_{CC} to FPS.

3.5 Thermal Shutdown (TSD): The MOSFETs and the control IC are built in one package. This allows the control IC to detect the abnormal over-temperature of the MOSFET. If the temperature exceeds approximately 130°C, the thermal shutdown triggers.

4. Soft-Start: At startup, the duty cycle starts increasing slowly to establish the correct working conditions for transformers, inductors, and capacitors. The voltage on the output capacitors is progressively increased to smoothly establish the required output voltage. Soft-start time is internally implemented for 15 ms (when the operating frequency is set to 100 kHz.) In addition, to help the soft-start operation, a capacitor and a resistor would be connected on the R_T pin externally, as shown in Figure 24. Before the power supply is powered on, the

capacitor C_{SS} remains fully discharged. After power-on, C_{SS} becomes charged progressively by the current through the R_T pin, which determines the operating frequency. The current through the R_T pin is inversely proportional to the total impedance of the connected resistors. The total impedance at startup is lower than that of the normal operation because R_{SS} is added on R_{SET} in parallel, which means the operating frequency decreases continuously from higher to nominal. Eventually C_{SS} is fully charged to the R_T pin voltage and the operating frequency is determined by R_{SET} only.

During the charging time of C_{SS} , the operating frequency is higher than during normal operation. In asymmetric half-bridge converters, a switching period contains powering and commutation periods. The energy cannot be transferred to the output side during commutation period. Since the DC link voltage applied to the V_{DL} pin and the leakage inductance of the main transformer are fixed, the powering period over the switching period is shorter in high switching frequencies. As C_{SS} is charged, the switching frequency decreases and the powering period over the switching period increases as well. It is helpful to start SMPS softly with the internal soft-start time together.



Figure 24. External Soft-Start Circuit

5. Startup: Due to the imbalance of the turn-off resistance between the high- and low-side MOSFETs, the voltage across the DC blocking capacitor cannot be predicted at startup. Additionally, the high-side MOSFET starts with a large duty cycle since the duty cycle of the low-side MOSFET increases step-by-step during soft-start time. Therefore, in the case where high voltage is already charged in the DC blocking capacitor due to the higher turn-off resistance of the high-side MOSFET before startup, a large primary current could flow through the high-side MOSFET during turn-on time after startup.

For the high-side MOSFET, a long duty cycle and high applied voltage make an excessive primary current. When the high-side MOSFET turns off, the primary current flows back to the DC link capacitor through the body diode of the low-side MOSFET. It keeps the same status even after turning on and off the low-side MOSFET. When the high-side MOSFET turns on again, a huge current can flow from the DC link capacitor through the channel of the high-side MOSFET and body diode of the low-side one due to the reverse recovery. It may induce unexpected noise into CS pin.

To avoid this issue, the voltage across the DC blocking capacitor must be low enough. In general, two resistors with several MHz can be added on the drain-to-source terminals of each MOSFET to divide the DC link voltage.

6. Burst Operation: To minimize power dissipation in standby mode, the FSFA2100 enters burst-mode operation. As the load decreases, the feedback voltage decreases. As shown in Figure 25, the device automatically enters burst mode when the feedback voltage drops below V_{BL} (1.3 V). At this point, switching stops and the output voltages start to drop at a rate dependent on standby current load. This causes the feedback voltage to rise. Once it passes V_{BH} (1.5 V), switching resumes. The feedback voltage then falls and the process repeats. Burst-mode operation alternately enables and disables switching of the MOSFETs, thereby reducing switching loss in standby mode.



Application	FPS™ Device	Input Voltage Range	Rated Output Power	Output Voltage (Rated Current
LCD TV	FSFA2100	400 V	200 W	25 V-8 A
Reduced EMI	stem Reliability with	input) o-Voltage-Switching (ZVS) Various Protection Functions	R211 C211	
+ V _{IN} =400V (from PFC output) + ZZ	C107 + 0.68µF 227 R105 27k	E FB Control IC VCTR Control VCTR Control FB Control Control FB Control	Np Ns D211 FFPP20UP20DN C D212 FFP20UP20DN R202 1k S R202 1k C C212 150 680pF/1kV	C201 C202 2200µF 2200µF 35V 35V + + + - - - - - - - - - - - - - - - -
		^{₀₂} [♥] Figure 26. Typical Application	ation Circuit	

Typical Application Circuit (Continued) Core: EER3542 (Ae=107 mm²) Bobbin: EER3542 (Horizontal) EER3542 16 1 Np N. s1 1 1 N_{s2} 9 8 Figure 27. Core and Winding

	Pin (S \rightarrow F)	Wire	Turns	Winding Method
N _p	8 → 1	0.12φ×30 (Litz Wire)	50	Solenoid Winding
N _{s1}	16 → 13	0.1φ×100 (Litz Wire)	8	Solenoid Winding
N _{s2}	12 ightarrow 9	0.1φ×100 (Litz Wire)	8	Solenoid Winding

	Pin	Specification	Remark
Inductance	1-8	630 μH ± 5%	100 kHz, 1 V
Leakage	1-8	45 μH ± 10%	Short One of the Secondary Windings



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